

1. Scope

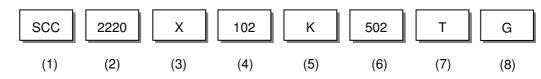
The SCC series X2, X1/Y2 safety capacitors are designed specifically for use in modem, facsimile,

telephone and other electronic equipment.

These parts are compliant to EN60384-14, IEC60384-14, UL60384-14, CSA 60384-1 & CSA 60384-14.

(This product compliant with the RoHS & HF and Pb free.)

2. Parts Number Code



(1)Product

| Product Code | |
|--------------|---------------------------------|
| SCC | Safety Approval of MLCC Product |

(2)Chip Size

| 0 1 | | |
|------|--------------|-----------------|
| Code | Length×Width | unit : mm(inch) |
| 1808 | 4.60× 2.00 | (.18× .08) |
| 1812 | 4.60× 3.20 | (.18× .12) |
| 2208 | 5.70× 2.00 | (.22× .08) |
| 2211 | 5.70× 2.80 | (.22× .11) |
| 2220 | 5.70× 5.00 | (.22× .20) |
| 2825 | 7.10× 6.35 | (.28× .25) |

(3) **Temperature Characteristics**

| CodeTemperature | | Temperature | Temperature |
|-----------------|----------------|-------------------|-------------------|
| | Characteristic | Range | Coefficient |
| N | NPO | -55°C∼+125°C | 30 ppm/° C |
| Х | X7R | -55℃~+125℃ | ± 15% |

| Code | Tolerance | Nominal Capacitance |
|------|-----------|---------------------|
| С | ± 0.25 pF | Less Than 10 pF |
| D | ± 0.50 pF | (Include 10 pF) |
| E | ± 1.00 pF | _ |
| J | ± 5.00 % | More Than 10 pF |
| K | ± 10.0 % | _ |
| М | ± 20.0 % | _ |
| Q | +10%~+20% | _ |

(6) Class Level of Capacitors

| Code | Class |
|------|-----------------------------------|
| 202 | Х2 |
| 252 | X2 (305Vac) |
| 502 | X1/Y2 |
| 602 | X1/Y2 for |
| | SCC2208N,SCC2211N,SCC2220N Series |

| (4) | Car | oaci | tan | ce |
|-----|-----|------|-----|----|
| | | | | |

| (4)Capacitance | unit :pico farads(pF) |
|----------------|--------------------------|
| Code | Nominal Capacitance (pF) |
| 5R0 | 5.0 |
| 330 | 33.0 |
| 151 | 150.0 |
| 102 | 1,000.0 |
| 103 | 10,000.0 |

※. If there is a decimal point, it shall be expressed by an English capital letter R

(7)Tapping

| Code | Туре |
|------|-------------|
| Т | Tape & Reel |
| В | Bulk |

(8)Special Requirement Code

| Code | Туре | |
|------|--------------|--|
| G | Pb free Type | |



3. Nominal Capacitance and Tolerance

3.1 Standard Combination of Nominal Capacitance and Tolerance

| Class | Characteristic | Toler | ance | Nominal Capacitance | | |
|-------------|----------------|------------------------------|---------------|-------------------------------|--|--|
| Class | NPO | Less Then 10 pF | C (± 0.25 pF) | 0.5,1,1.5,2,2.5,3,3.5,4,4.5,5 | | |
| Ι | | D (± 0.50 pF) 5 | | 5,6,7,8,9,10 | | |
| | | E (± 1.00 pF) | | 6,7,8,9,10 | | |
| | | More Than 10 pF J (± 5.00 %) | | E-24 series | | |
| | | | K (± 10.0 %) | | | |
| Class II | X7R | K (± 10.0 %), M (± 20.0 %) | | E-12 series | | |

3.2 E series(standard Number)

| Standard No. | Application Capacitance | | | | | | | | | | | |
|--------------|-------------------------|-----|---------|-----|-----|-----|-----|-----|-----|-----|-----|-----|
| E- 3 | | 1 | .0 | | | 2.2 | | | 4.7 | | | |
| E- 6 | 1.0 1.5 | | 2.2 3.3 | | 4.7 | | 6.8 | | | | | |
| E-12 | 1.0 | 1.2 | 1.5 | 1.8 | 2.2 | 2.7 | 3.3 | 3.9 | 4.7 | 5.6 | 6.8 | 8.2 |
| E-24 | 1.0 | 1.2 | 1.5 | 1.8 | 2.2 | 2.7 | 3.3 | 3.9 | 4.7 | 5.6 | 6.8 | 8.2 |
| | 1.1 | 1.3 | 1.6 | 2.0 | 2.4 | 3.0 | 3.6 | 4.3 | 5.1 | 6.2 | 7.5 | 9.1 |

4. Operation Temperature Range

| Class | Characteristic | Temperature Range | Reference Temp. |
|-------|----------------|-------------------|-----------------|
| Ι | NPO | -55℃ ~ +125℃ | 25 ℃ |
| Π | X7R | -55℃ ~ +125℃ | 25°C |

5. Storage Condition

Storage Temperature : 5 to 40 $^\circ\!\!\!\mathrm{C}$

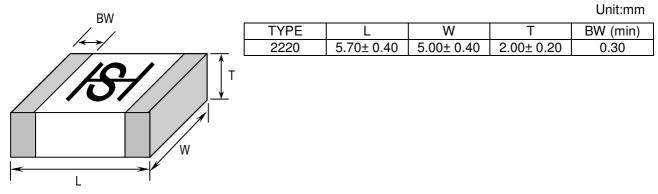
Relative Humidity : 20 to 70 %

Storage Time: 12 months max.

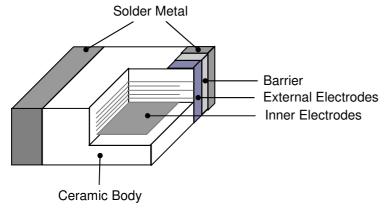


6. Dimensions

6.1 Configuration and Dimension :



6.2 Termination Type :





7. Electronic Nominal Specification

7.1 Safety Standard:

TUV : IEC 60384-14:2013 EN 60384-14:2013 UL :UL 60384-14 CSA 60384-1 & CSA 60384-14

| Temperature Characteristic | Class | Size | Rated Voltage | Certificated | | C 10 | apacita 10 | ance Rango 1 1 | e (pF) 02 | 103 |
|-------------------------------|-------|------|------------------|--------------|---|---------|---------------|-------------------|--------------|-------|
| NPO | X2 | 1808 | 250 Vrms | TUV/UL | 2 | | | | 1000 | |
| X7R | X2 | 1808 | 250 Vrms | TUV/UL | | | 150 | | 2200 | |
| X7R | X2 | 1812 | 250 Vrms | TUV/UL | | | 3 | 30 | 470 | 00 |
| X7R | X2 | 2220 | 250 Vrms | TUV/UL | | | 150 | | | 33000 |
| X7R | X2 | 2825 | 250 Vrms | UL | | | | 47 | 7000 | 5600 |
| NPO | X1/Y2 | 1808 | 250 Vrms | TUV/UL | 2 | | | 330 | | |
| X7R | X1/Y2 | 1808 | 250 Vrms | TUV/UL | | | 150 | | 1000 | |
| NPO | X1/Y2 | 1812 | 250 Vrms | TUV/UL | 2 | | | 68 | 0 | |
| X7R | X1/Y2 | 1812 | 250 Vrms | TUV/UL | | | 130 | | 1000 | |
| NPO | X1/Y2 | 2208 | 250 Vrms | TUV/UL | 2 | | | 330 | | |
| X7R | X1/Y2 | 2208 | 250 Vrms | TUV/UL | | 36 | | | 1000 | |
| NPO | X1/Y2 | 2211 | 250 Vrms | TUV/UL | 2 | | | | 1000 | |
| X7R | X1/Y2 | 2211 | 250 Vrms | TUV/UL | | | 68 | | 2700 | |
| NPO | X1/Y2 | 2220 | 250 Vrms | TUV/UL | 2 | | | | 1200 | |
| X7R | X1/Y2 | 2220 | 250 Vrms | TUV/UL | | | 100 | | 470 | 0 |
| X7R | X2 | 2220 | 305 Vrms | TUV/UL | | | 150 | | | 33000 |



8. Performance

| No. | lto | m | Sno | oification | Test Condition | | |
|-----|-----------------------------|--------------------------|--|------------------------------------|--|--|--|
| | Ite | | • | cification | | | |
| 1 | Visi | | No abnormal exter | | Visual Inspection | | |
| 2 | Dimer | | See Page 3 / Item | | Visual Inspection | | |
| 3 | Capac | | Within the specifi | ed tolerance | Char. Frequency Voltage | | |
| 4 | Q and Dissipation Factor | | More than $30pF : Q \ge 1000$ $30pF \& below: Q \ge 400 + 20C$ (C:pF) Class II (X7R) Maximum : 2.5% (0.025) | | $\label{eq:rescaled} \begin{array}{c c} NPO & \\ C \leq 1000 pF & 1MHz \pm 10\% & 1.0 \pm 0.2 Vrms \\ \hline C > 1000 pF & 1KHz \pm 10\% & \\ \hline & \\ \hline & \\ \hline & \\ X7R & 1KHz \pm 10\% & 1.0 \pm 0.2 Vrms \\ \hline & \\ After performing deage at 150 \pm 5\% \text{ for } 30 min. \end{array}$ | | |
| | | | | | and placement room temperature for 24±2hr. | | |
| 5 | Insula Resist | | Minimum 10,000M | Ω | Applied Voltage: Applied Voltage:500V Charge Time : 60sec. | | |
| 6 | Resistance Voltage Proof | | breakdown | | Applied Voltage: X Capacitor :Applied Voltage 1075Vdc(4.3Ur) Y Capacitor :Applied Voltage 1500Vac For 1min. Voltage ramp up rate ≤ 150V/sec(for Vac Test) charge/discharge Current is less than 50mA. | | |
| 7 | 7 Solderability | | More than 90% of the terminal surface is to be soldered newly, so metal part does not come out or dissolve | | | | |
| 8 | Resistance to | Appear- ance | No mechanical da | mage shall occur. | Bending shall be applied to the 1.0 mm with | | |
| | Flexure | Capacit- | Characteristic | Cap. Change | 1.0 mm/sec. | | |
| | of Substrate | ance | Class I (NPO) | ≤ ± 5.0% of initial value | The duration of the applied forces shall be 5 ± 1sec | | |
| | | | Class II (X7R) | $\leq \pm 12.5\%$ of initial value | Ending Limit | | |
| | | Q / tan δ | To satisfy the spec | ified initial value | | | |
| | | Insulation Resistance | To satisfy the spec | cified initial value | Solder the capacitor on P.C. board shown in | | |
| | Voltage Proof | | To satisfy the specified initial value | | Fig 1. before testing. | | |
| 9 | Robustness of | | No indication of pe the terminal electre | | Pull force shall be applied for 10 ± 1 second. ≤ 0603 5N($= 0.5$ Kg·f) | | |
| | Shear | Capacit- | Characteristic | Cap. Change | >060310N(=1.0 Kg·f) | | |
| | | ance | Class I (NPO) | $\leq \pm 5.0\%$ of initial | | | |
| | | | | value | | | |
| | | | Class II (X7R) | ≤ ± 12.5% of initial value | N·f | | |
| | | Q / tan δ | To Satisfy The Spe | |] | | |
| | | Insulation Resistance | To Satisfy The Spe | | Solder the capacitor on P.C. board shown in Fig 1. before testing. | | |
| | | Voltage Proof | To Satisfy The Spe | ecified Initial Value | | | |



| No. | lte | Item Specification | | Test Condition | |
|-----|------------------|--------------------|--|-----------------------------|--|
| 10 | Resistance To | Appear- ance | No mechanical d | amage shall occur. | Class II capacitor shall be set for 48±4 hours at room temperature after one hour heat |
| | Soldering | Capacit- | Characteristic | Cap. Change | treatment at 150 +0/-10 $^{\circ}$ C before initial |
| | Heat | ance | Class I (NPO) | $\leq \pm 10\%$ of initial | measure. |
| | | | | value | Preheat : At 150± 10℃ For 60~120sec. |
| | | | Class II (X7R) | $\leq \pm 20\%$ of initial | Dip : Solder Temperature of 260± 5℃ |
| | | | | value | Dip Time : 10 ± 1sec. |
| | | Q / Tan δ | To satisfy the spe | ecified initial value | Flux :Rosin Measure at room temp. after cooling for: |
| | | Insulation | More than 1,000 | MΩ | Class I : 24 \pm 2 Hours |
| | | Resistance | | | Class II : 48 \pm 4 Hours |
| | | Voltage Proof | To Satisfy The S | pecified Initial Value | |
| 11 | Damp Heat / | Appear- ance | No mechanical d | amage shall occur. | Test Condition : Temperature : 40℃ |
| | | Capacit- | Characteristic | Cap. Change | Humidity : 95 %RH |
| | State | ance | Class I (NPO) | $\leq \pm 15\%$ of initial | Test Time : 500hr (21days) |
| | | | | value | The capacitors with rated voltage(250Vac) |
| | | | Class II (X7R) | ≤ ± 15% of initial value | applied. Measure at room temp. after cooling for: |
| | | Q Class I | More Than 30pF 30pF & Below:Q (C:pF) | | Class I :24 ± 2 Hrs Class II :48 ± 4 Hrs |
| | | Tan δ Class ∏ | Maximum 5.0% | | Solder The Capacitor On P.C. Board Shown In Fig 2. Before Testing. |
| | | | More Than 1,000 | MΩ | |
| | | Voltage Proof | To Satisfy The Specified Initial Value | | |
| 12 | Endurance | Appear- | No Mechanical | Damage Shall Be | Impulse Voltage |
| | | ance | Occur | | Each individual capacitor shall be subjected |
| | | Capacit- | Characteristic | Cap. Change | to a 2.5KV(X2) and 5KV(X1/Y2) impulse for three times. Then the capacitors are applied |
| | | ance | Class I (NPO) | $\leq \pm 20\%$ of initial | to life test. |
| | | | Class II (X7R) | value ≤ ± 20% of initial | (%) Front time T ₁ =1.2µs=1.67T |
| | | | $Class II (\Lambda / \Pi)$ | value | 100 Time to half-value $T_2=50\mu s$ |
| | | Q | More Than 30pF | | 90 |
| | | Class I | 30pF & Below:Q | | |
| | | Tan δ | Maximum 5.0% | | 50 |
| | | Class II | | | 30 |
| | | Insulation | Minimum 1,000M | 1Ω | 30 |
| | | Resistance | | | 0 |
| | | Voltage | To satisfy the spe | ecified initial value | t t |
| | | Proof | | | •TT_2 |
| | | | | | |
| | | | | | Temperature : 125℃ |
| | | | | | Test Time : 1000hrs |
| | | | | | Applied Voltage : Class X Capacitors :1.25Ur (312.5Vac) |
| | | | | | Class Y Capacitors :1.2001 (312.50ac) Class Y Capacitors :1.70Ur (425Vac) |
| | | | | | Except that once every hour the voltage |
| | | | | | shall be increased to 1000Vrms for 0.1s. |
| | | | | | |
| | | | | | Additional impulse 2.5KV of Y3 for EN60950 standard. |

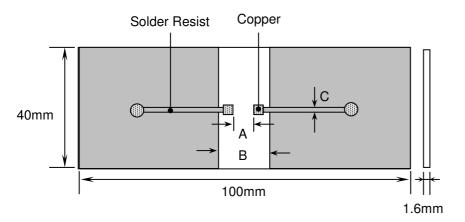


| No. | Item | Specification | Test Condition |
|-----|------------------------|-------------------------------|---|
| 13 | Passive Flammability | Capacitor didn't burnt at all | Volume Sample : 21.56mm ³ Flame exposure time : 5 sec.Max. |
| | Active Flammability | a flame | The capacitors of class each test capacitors applied Ur(250Vac). Then each sample shall be subjected to 20 discharges from a tank capacitor, charge to a voltage that, when discharged, places Ui(2500V) across the capacitor under test. The interval |
| | | | between successive discharges shall be 5s. |



Fig.1

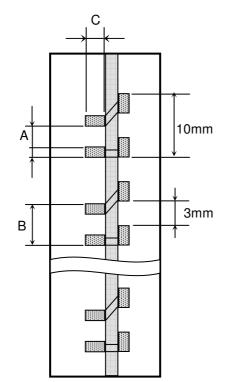
P.C. Board for Bending Strength Test



(referring to IEC384-14 and EN132400)

Material : Glass Epoxy Substrate : Copper (Thickness : 0.035mm) : Solder Resist

Fig.2 Test Substrate



Material : Glass Epoxy Substrate : Copper (Thickness : 0.035mm) : Solder Resist

Thickness : 1.6 mm

Unit:mm

| Туре | A | В | С |
|------|-----|-----|-----|
| 1206 | 2.2 | 5.0 | 2.0 |
| 1808 | 3.5 | 7.0 | 2.5 |
| 1812 | 3.5 | 7.0 | 3.7 |
| 2208 | 4.5 | 8.0 | 2.5 |
| 2211 | 4.5 | 8.0 | 3.0 |
| 2220 | 4.5 | 8.0 | 5.6 |

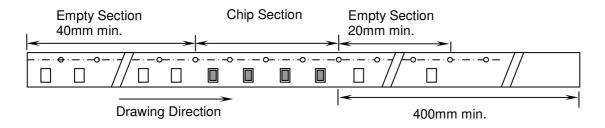


9. Packing

9.1 Bulk Packing

According to customer request.

9.2 Chip Capacitors Tape Packing



9.3 Material And Quantity

| Tape | | 1206 | | |
|----------|----------------|-------------------------|----------------|--|
| Material | T≦0.90mm | $0.90mm < T \le 1.25mm$ | T>1.25mm | |
| Plastic | 4,000 pcs/Reel | 3,000 pcs/Reel | 2,000 pcs/Reel | |

| Tape | 18 | 08 | 1812/2208/2211/2220 | | |
|----------|------------------------|------------------------------|---------------------------------|--------------|--|
| Material | $0.9mm < T \le 1.25mm$ | 1.25 mm $<$ T \leq 2.0mm | 1.25 mm $<$ T \leq 2.2 mm | T>2.2mm | |
| Plastic | 3000 pcs/Reel | 2000 pcs/Reel | 1000 pcs/Reel | 700 pcs/Reel | |

| Tape | 2825 |
|----------|--------------|
| Material | T>2.6mm |
| Plastic | 400 pcs/Reel |

9.4 Cover Tape Reel Off Force

9.4.1 Peel-Off Force

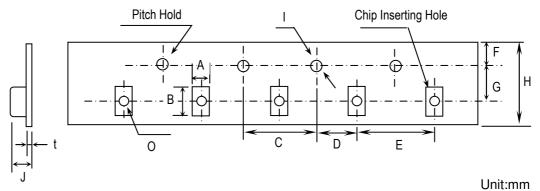
5 g·f \leq Peel-Off Force \leq 70 g·f

9.4.2 Measure Method



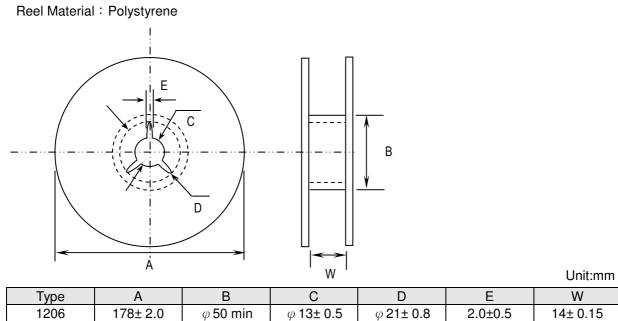


9.5 Plastic Tape



| Туре | А | В | С | D | E | F |
|----------------------|-----------|------------|--------------|---------------|-----------|-----------|
| 1206 | 1.9± 0.2 | 3.5± 0.2 | 4.0± 0.1 | 2.0 ± 0.05 | 4.0± 0.1 | 1.75± 0.1 |
| 1808 | 2.5±0.2 | 4.9±0.2 | | | | |
| 1812 | 3.6±0.2 | 4.9±0.2 | | | 8.0± 0.1 | |
| 2208 | 2.5±0.2 | 6.1±0.2 | | | | |
| 2211 | 3.2±0.2 | 6.1±0.2 | | | | |
| 2220 | 5.4±0.2 | 6.1±0.2 | | | | |
| 2825 | 6.7±0.2 | 7.5±0.2 | | | 12.0± 0.1 | |
| Туре | G | Н | I | J | + | 0 |
| | | | | | | |
| 1000 | . | | | - | | |
| 1206 | 5.5± 0.05 | 12.0 ± 0.3 | φ 1.5+0.1/-0 | 3.7 max. | 0.3 max. | 1.0± 0.1 |
| 1206 1808 | . | | φ 1.5+0.1/-0 | - | 0.3 max. | |
| | . | | φ 1.5+0.1/-0 | - | 0.3 max. | 1.0± 0.1 |
| 1808 | . | | φ 1.5+0.1/-0 | - | 0.3 max. | 1.0± 0.1 |
| 1808 1812 | . | | φ 1.5+0.1/-0 | - | 0.3 max. | 1.0± 0.1 |
| 1808 1812 2208 | . | | φ 1.5+0.1/-0 | - | 0.3 max. | 1.0± 0.1 |

9.6 Reel Dimensions



| Type | A | В | C | D | E | W |
|------|----------|--------------|---------------|-------------------|---------|----------|
| 1206 | 178± 2.0 | arphi 50 min | arphi 13± 0.5 | φ 21± 0.8 | 2.0±0.5 | 14± 0.15 |
| 1808 | | | | | | |
| 1812 | | | | | | |
| 2208 | | | | | | |
| 2211 | | | | | | |
| 2220 | | | | | | |
| 2825 | | | | | | |



Caution

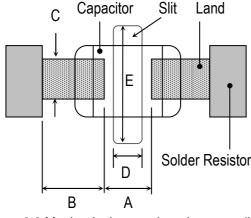
1. Storage

Store the capacitors where the temperature and relative humidity don't exceed 40 °C and 70%RH. We recommend that the capacitors be used within 12 months from the date of manufacturing. Store the products in the original package and do not open the outer wrapped, polyethylene bag, till just before usage. If it is open, seal it as soon as possible or keep it in a desiccant with a desiccation agent.

2. Construction of Board Pattern

Improper circuit layout and pad/land size may cause excessive or not enough solder amount on the PC board. Not enough solder may create weak joint, and excessive solder may increase the potential of mechanical or thermal cracks on the ceramic capacitor. Therefore we recommend the land size to be as shown in the following table:

2.1 Size and recommend land dimensions for reflow soldering.



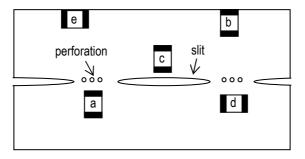
| | EIA Code | Chip | (mm) | | | Land (mm) | | |
|-------------------|----------|------|------|---------|---------|-----------|---------|---------|
| | | Γ | W | Α | В | С | D | E |
| | 1808 | 4.60 | 2.00 | 2.8~3.4 | 1.2~1.4 | 1.5~1.8 | 1.0~2.8 | 3.6~4.1 |
| • | 1812 | 4.60 | 3.20 | 2.8~3.4 | 1.2~1.4 | 2.3~3.0 | 1.0~2.8 | 4.8~5.3 |
| | 2208 | 5.70 | 2.00 | 4.0~4.6 | 1.4~1.6 | 1.5~1.8 | 1.0~4.0 | 3.6~4.1 |
| | 2211 | 5.70 | 2.80 | 4.0~4.6 | 1.4~1.6 | 2.0~2.6 | 1.0~4.0 | 4.4~4.9 |
| | 2220 | 5.70 | 5.00 | 4.0~4.6 | 1.4~1.6 | 3.5~4.8 | 1.0~4.0 | 6.6~7.1 |
| l Ier Resistor | | | | | | | | |

2.2 Mechanical strength varies according to location of chip capacitors on the P.C. board.

Design layout of components on the PC board such a way to minimize the stress imposed on the components, upon flexure of the boards in depanelization or other processes.

Component layout close to the edge of the board or the "depanelization line" is not recommended.

Susceptibility to stress is in the order of: a>b>c and d>e



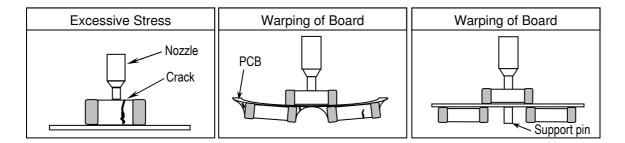


2.3 Layout Recommendation

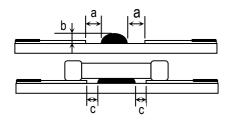
| Example | Use of Common Solder Land | Solder With Chassis | Use of Common Solder Land With Other SMD |
|----------------|--|--|---|
| Need to Avoid | Lead Wire Chip Solder | Chassis \downarrow Excessive Solder \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow \downarrow | Solder Land |
| Recommendation | Lead Wire Chip Solder Resist Adhesive PCB Solder Land | Solder Resist | Solder Land |

3. Mounting

3.1 Sometimes Crack is caused by the impact load due to suction nozzle in pick and place operation. In pick and place operation, if the low dead point is too low, excessive stress is applied to component. This may cause cracks in the ceramic capacitor, therefore it is required to move low dead point of a suction nozzle to the higher level to minimize the board warp age and stress on the components. Nozzle pressure is typically adjusted to 1N to 3N (static load) during the pick and place operation.



3.2 Amount of Adhesive



Example : 0805 & 1206

| а | 0.2mm min. |
|------------------------------|-------------|
| b | 70 ~ 100 μm |
| C Do not touch the solder la | |

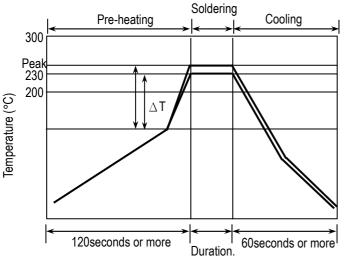


4. Soldering

4.1. Wave Soldering

Most of components are wave soldered with solder at Peak Temperature. Adequate care must be taken to prevent the potential of thermal cracks on the ceramic capacitors. Refer to the soldering methods below for optimum soldering benefits.

Recommend flow soldering temperature Profile



| Soldering Method | Peak Temp.($^{\circ}$ C) / Duration (sec) |
|------------------|--|
| 1206 and Under | ΔT ≤ 100~130 max. |
| Pb-Sn Solder | 250°C (max.) / 3sec(max.) |
| Lead Free Solder | 260°C (max.) / 5sec(max.) |

Recommended solder compositions

Sn-37Pb (Pb - Sn Solder)

Sn-3.0Ag-0.5Cu (Lead Free Solder)

To optimize the result of soldering, proper preheating is essential:

- 1) Preheat temperature is too low
 - a. Flux flows to easily
 - b. Possibility of thermal cracks
- 2) Preheat temperature is too high
 - a. Flux deteriorates even when oxide film is removed
 - b. Causes warping of circuit board
 - c. Loss of reliability in chip and other components

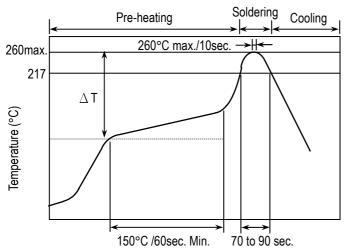
Cooling Condition:

Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (Δ T) between the solvent and the chips must be less than 100 °C.

4.2 Reflow Soldering

Preheat and gradual increase in temperature to the reflow temperature is recommended to decrease the potential of thermal crack on the components. The recommended heating rate depends on the size of component, however it should not exceed 3° C/Sec.

Recommend reflow profile for Lead-Free soldering temperature Profile (MIL-STD-202G #210F)



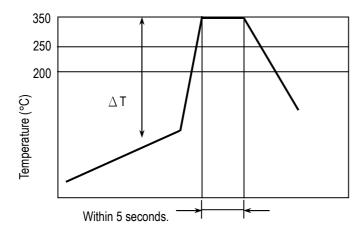
✗ The cycles of soldering : Twice (max.)

| Soldering Method | Change in Temp.(°C) |
|------------------|--|
| 1206 and Under | $\Delta T \leq 190 \ ^{\circ}\mathrm{C}$ |
| 1210 and Over | ∆T ≦ 130 °C |



4.3 Hand Soldering

Sudden heating of the components results in distortion due to a high internal temperature differential, causing cracked chips. When preheating, keep temperature differential Δ T, within the range shown in table. The smaller the Δ T, the less stress on the chip.



| Soldering Method | Change in Temp.(°C) |
|------------------|------------------------------|
| 1206 and Under | $\Delta T \leq 150 \ { m C}$ |
| 1210 and Over | $\Delta T \leq 130 \ { m C}$ |

How to Solder Repair by Solder Iron

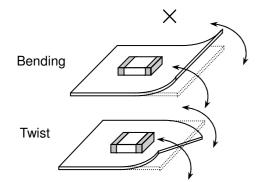
1) Selection of the soldering iron tip

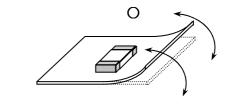
Tip temperature of solder iron various by its type, P.C.board material and solder land size. Higher the tip temperature, quick the operation is .but the heat shock may crack the chip capacitor.

- 2) recommended solder iron condition
 - a.) Preheating Condition : Board and components should be preheated sufficiently at 150 ℃ or over, and soldering should be conducted with soldering iron as boards and components are maintained at sufficient temperatures.
 - b.) Soldering iron power shall not exceed 30 W.
 - c.) Soldering iron tip diameter shall not exceed 3mm.
 - d.) Temperature of iron tip shall not exceed 350 °C and the process should be finished within 5 seconds. (refer to MIL-STD-202G)
 - e.) Do not touch the ceramic dielectric with solder iron other than the terminations. Direct contact of the soldering iron with ceramic dielectric of chip capacitor may cause crack.
 - f.) After soldering ,let the products to cool down gradually in the room temperature.
- ***** The soldering to lose the use of electronic heat gun.

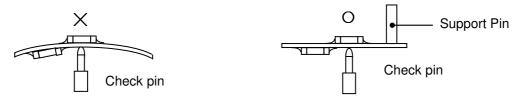
5. Handling after chip mounted

5.1 Please pay attention put the component lateral to the direction in which stress acts.





5.2 Crack will be caused if board is warped due to excessive load by check pin.



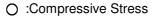
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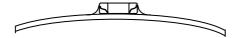


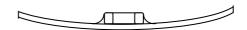
CERTIFIED SAFETY CAPACITORS

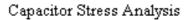
- 5.3 Mechanical stress due to warping and torsion by dividing.
 - (a) Crack occurrence ratio will be increased by manual separation.
 - (b) Crack occurrence ratio will be increased by tensile force , rather than compressive force.

imes :Tensile Stress

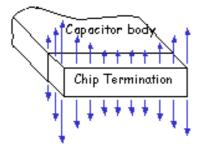


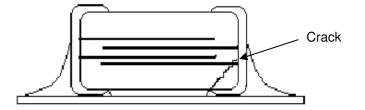






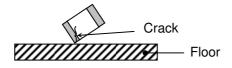




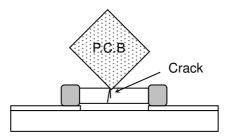


6. Handling of Loose Chip Capacitor

6.1 If dropped the chip capacitor may crack.



6.2 Piling the P.C. board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitor of another of board to cause crack.



7. Safekeeping condition and period

For safekeeping of the products, we recommend to keep storage temperature +5 ~+40 $^\circ C$, Humidity 20 ~70%RH and use them within 12 months.



单击下面可查看定价,库存,交付和生命周期等信息

>>Holy Stone(禾伸堂)